

<b>Notice of References Cited</b>	Application/Control No. 10/716,190		Applicant(s)/Patent Under Reexamination KOIDE ET AL.	
	Examiner EDMUND H. LEE		Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,443,378	08-1995	Jaroschek et al.	425/130
*	B	US-5,792,397	08-1998	Ritchey, Eugene B.	264/40.7
*	C	US-4,174,413	11-1979	Yasuike et al.	428/35.7
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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